

<b>Notice of References Cited</b>	Application/Control No. 10/531,527		Applicant(s)/Patent Under Reexamination XU ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,662,017 B2	12-2003	McCann et al.	455/461
*	B	US-6,839,421 B2	01-2005	Ferraro Esparza et al.	379/220.01
*	C	US-7,577,431 B2	08-2009	Jiang, Yue Jun	455/432.1
*	D	US-7,664,495 B1	02-2010	Bonner et al.	455/433
*	E	US-2006/0276226 A1	12-2006	Jiang, Yue Jun	455/558
*	F	US-5,307,400 A	04-1994	Sawyer et al.	455/456.1
*	G	US-5,884,179 A	03-1999	Patel, Mahesh	455/445
*	H	US-5,953,663 A	09-1999	Maupin et al.	455/433
*	I	US-6,049,714 A	04-2000	Patel, Mahesh	455/433
*	J	US-6,064,887 A	05-2000	Kallioniemi et al.	455/445
*	K	US-6,138,023 A	10-2000	Agarwal et al.	455/445
*	L	US-6,192,242 B1	02-2001	Rollender, Douglas Harold	455/433
*	M	US-6,240,293 B1	05-2001	Koster, Karl H.	455/445

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

#### NON-PATENT DOCUMENTS

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,347,085 B1	02-2002	Kelly, Keith C.	370/352
*	B	US-6,366,663 B1	04-2002	Bauer et al.	379/221.13
*	C	US-6,564,055 B1	05-2003	Hronek, Daniel J.	455/433
*	D	US-6,625,273 B1	09-2003	Ashdown et al.	379/221.13
*	E	US-6,662,017 B2	12-2003	McCann et al.	455/461
*	F	US-6,678,265 B1	01-2004	Kung et al.	370/352
*	G	US-6,725,044 B2	04-2004	Verma et al.	455/444
*	H	US-6,819,921 B2	11-2004	Mazzarella et al.	455/419
*	I	US-7,079,511 B2	07-2006	Abrol et al.	370/331
*	J	US-7,502,615 B2	03-2009	Wilhoite et al.	455/442
*	K	US-2002/0052211 A1	05-2002	Kim et al.	455/461
*	L	US-2002/0147008 A1	10-2002	Kallio, Janne	455/426
*	M	US-2003/0054809 A1	03-2003	Bridges et al.	455/419

#### FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0099935 A1	05-2006	Gallagher et al.	455/414.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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	V	
	W	
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